Index of Claims

Appl	ica	tion/	Con	trol	No.	

10754701

DAO H NGUYEN

Applicant(s)/Patent Under Reexamination SEMICONDUCTOR ENERGY LAB

Examiner

Art Unit

2818

✓	Rejected
=	Allowed

-	Cancelled
÷	Restricted

N	Non-Elected
1	Interference

Α	Appeal
0	Objected

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Index of Claims

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Appl	icati	ion/	Cor	itrol	No.	

10754701

DAO H NGUYEN

Examiner

Applicant(s)/Patent Under Reexamination SEMICONDUCTOR ENERGY LAB

701

Art Unit

2818

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N	Non-Elected
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	Claims renumbered in the same order as presented by applicant						☐ CPA	□ т.:		R.1.47
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Index of Claims



Appl	icati	ion/	Con	trol	No.	

10754701

DAO H NGUYEN

Applicant(s)/Patent Under Reexamination SEMICONDUCTOR ENERGY LAB

Examiner

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1	Interference

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Index of Claims

Application/Control No.	Applicant(s)/Patent Under Reexamination
10754701	SEMICONDUCTOR ENERGY LAB
Examiner	Art Unit
DAO H NGUYEN	2818

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